

IEC TS 62153-4-1

Edition 1.0 2020-05

TECHNICAL SPECIFICATION



AMENDMENT 1

Metallic communication cable test methods -PREVIEW Part 4-1: Electromagnetic compatibility (EMC) - Introduction to electromagnetic screening measurements

> IEC TS 62153-4-1:2014/AMD1:2020 https://standards.iteh.ai/catalog/standards/sist/12d91b92-a840-4568-a75cbaf6d6e7032d/iec-ts-62153-4-1-2014-amd1-2020





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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ICS 33.100.10

ISBN 978-2-8322-8044-7

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FOREWORD

This amendment has been prepared by IEC technical committee 46: Cables, wires, waveguides, RF connectors, RF and microwave passive components and accessories.

The text of this amendment is based on the following documents:

DTS	Report on voting		
46/726/DTS	46/748/RVDTS		

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- transformed into an International standard,
- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

2 Normative references

Add to the following reference to Clause 2:

IEC 62153-4-9, Metallic communication cable test methods – Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method

Figure 86 – Principle test set-up for measuring the coupling attenuation of screened balanced or multipin connectors

Insert the following note before the title:

NOTE The balun transformer is not required in case of multiport VNA with mixed mode capabilities, see Annex A.

Add, after Clause 12, the following new Annexes A and B:

Annex A

(normative)

Mixed mode S-parameter

A.1 General

To measure the parameters like unbalance attenuation, coupling attenuation etc. of balanced cables, connectors and components, a differential signal is required. This can, for example, be generated by using a balun which converts the unbalanced signal of a 50 Ω network analyser into a balanced signal.

Alternatively, a balanced signal may be obtained by using a vector network analyser (VNA) having two generators with a phase shift of 180°. Another alternative is to measure with a multi-port VNA (virtual balun).

The properties of balanced pairs are determined mathematically from the measured values of each single conductor of the pair against reference ground. The coverable frequency range for the determination of the reflection and transmission characteristics of symmetrical pairs is no longer limited by the balun but by the VNA and the connection technique.

A.2 Definition of mixed mode S-parameters **PREVIEW**

The transmission characteristics of four poles or two ports, such as coaxial cables, may be described by the scattering parameter or abbreviated "S-parameter", see Figure A.1. In matrix notation it is written:



Figure A.1 – Common two-port network

The definition of the scattering matrix can be easily extended to arbitrary N gates, see Figure A.2. For a four-port, this results in:



Figure A.2 – Common four port network

A.3 Mixed mode S-parameter nomenclature

For the measurement of symmetrical two-ports, the physical ports of the multi-port VNA are combined into logical ports, see Figure A.3:



Figure A.3 – Physical and logical ports of a VNA

According to Figure A 4, the following nomenclature is used: VIEW				
\mathcal{S}_{xyA}	(standards.iteh.ai)			
https://standards baf 8.	IEC TS 62153-4-1:2014/AMD1:2020 teh.ai/cat:ahumben.of.the VNA-port with stimulus 68-a75c- 16c7032d/number2of.the VNA-port with response modus of the VNA-port with response IEC			
	s: Single ended			
Modus	d: Differential mode			



Accordingly, the S-parameters can be understood as ratios of power waves.

c: Common mode

$$S_{xyAB} = \frac{input \ signal \ at \ VNA - port \ A \ at \ modus \ x}{input \ signal \ at \ VNA - port \ B \ at \ modus \ y}$$
(A.3)

The conversion of the asymmetrical four-port scattering parameters S^{std} to mixed mode scattering parameters S^{mm} for a symmetrical two-port network is given by:

$$S^{mm} = M \times S^{std} \times M^{-1} \tag{A.4}$$

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$$M = \frac{1}{\sqrt{2}} \begin{bmatrix} 1 & -1 & 0 & 0 \\ 0 & 0 & 1 & -1 \\ 1 & 1 & 0 & 0 \\ 0 & 0 & 1 & 1 \end{bmatrix}$$
(A.5)

$$\mathbf{S}^{mm} = \begin{bmatrix} \begin{bmatrix} \mathbf{S}_{dd11} & \mathbf{S}_{dd12} \\ \mathbf{S}_{dd21} & \mathbf{S}_{dd22} \end{bmatrix} \begin{bmatrix} \mathbf{S}_{dc11} & \mathbf{S}_{dc12} \\ \mathbf{S}_{dc21} & \mathbf{S}_{dc22} \end{bmatrix} \\ \begin{bmatrix} \mathbf{S}_{cd11} & \mathbf{S}_{cd12} \\ \mathbf{S}_{cd21} & \mathbf{S}_{cd22} \end{bmatrix} \begin{bmatrix} \mathbf{S}_{cc11} & \mathbf{S}_{cc12} \\ \mathbf{S}_{cc21} & \mathbf{S}_{cc22} \end{bmatrix} \end{bmatrix}$$
(A.6)

The derivation of the mixed mode parameters (Formulae (A.4) to (A.6)) is described in Annex B.

For the measurement of a two-port with an unbalanced port (single ended) and a balanced port, e.g. to measure coupling attenuation according to IEC 62153-4-5 or to IEC 62153-4-9, the measurement configurations according to Table A.1 arise:

Table A.1 – Measurement configurations unbalanced – balanced

		(Stand	Stimulus				
		IEC TS 621	Single ended	20 Differential mode	Common mode		
https://standards.iteh.ai/catalog			stan dogicáli párt d 91b	2-a&ogical@ont72c-	Logical port 2		
Response	Single ended	2051carport-1/iec-	ts-62153 _S 4-1-2014-ar	nd1-2028 _{sd12}	S _{sc12}		
	Differential mode	Logical port 2	S _{ds21}	S _{dd22}	S _{dc22}		
	Common mode	Logical port 2	S _{cs21}	S _{cd22}	S _{cc22}		

The measurement of the coupling attenuation corresponds to a stimulus in the differential mode and to a response in the unbalanced (coaxial) mode (single ended), i.e. a measurement of the S-parameter S_{sd12} . The measurement of the screening attenuation corresponds to a stimulus in the common mode and to a response in the unbalanced (coaxial) mode (single ended), i.e. a measurement of the S-parameter S_{sc12} , see Figure A.5.



Figure A.5 – Balunless measuring of coupling attenuation, principle set-up with multiport VNA and standard head

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For the measurement of a two-port, the test configurations according to Table A.2 are obtained:

			Stimulus			
			Differential mode		Common mode	
			Logical port 1	Logical port 2	Logical port 1	Logical port 2
Response	Differential mode	Logical port 1	S _{dd11}	S _{dd12}	S _{dc11}	S _{dc12}
		Logical port 2	S _{dd21}	S _{dd22}	S _{dc21}	S _{dc22}
	Common mode –	Logical port 1	S _{cd11}	S _{cd12}	S _{cc11}	S _{cc12}
		Logical port 2	S _{cd21}	S _{cd22}	S _{cc21}	S _{cc22}

Tabla A	2 -	Massurament	configurations	halancod -	halancod
I able A		weasurement	configurations	palanceu -	Dalanceu

The measurement of the attenuation of a balanced pair corresponds to a stimulus and a response in differential mode, i.e. a measurement of the S-parameter S_{dd21} . The measurement of the unbalance attenuation with stimulus in differential mode and common mode response corresponds at the near end with the S-parameter S_{cd11} or S_{cd21} when measured at the far end.

A.4 Termination

A differential mode termination according to Figure A.6 and Figure A.7 is required for each pair at the near and far end of the caple dards.iteh.ai)



Figure A.6 – Termination network

$$R_{\rm DM} = \frac{Z_{\rm diff}}{2} \tag{A.7}$$

The termination of the common mode is 25 Ω (R_{CM} = 0).

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Figure A.7 – Termination of a screened symmetrical cable, principle

NOTE Since mixed mode VNAs use a 50 Ω generator and receiver impedance as default value, the common mode value results in 25 Ω . Teh STANDARD PREVIEW

A.5 Reference impedance of a MNAards.iteh.ai)

When measuring with a 4 port VNA with mixed mode parameters, a full 4-port calibration, e.g. with electronic calibration units shall be applied. The VNA ($Z_0 = 50 \Omega$ physical analyser ports) sets the default values reference impedances for the differential mode $Z_{0d} = 100 \Omega$ (= 2 × Z_0) and for the common mode $Z_{0c} = 25 \Omega$ (= $Z_0/2$).

A.6 TP-connecting unit

When measuring balunless respectively with "virtual balun", a TP connecting unit is required. The TP-connecting unit performance requirements are given in Table A.3.